



# STL60N32N3LL

Dual N-channel 30 V, 0.006  $\Omega$ , 15 A PowerFLAT™5x6 asymmetrical double island, STripFET™ Power MOSFET

Target specification

## Features

Type		V <sub>DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>
STL60N32N3LL	Q <sub>1</sub>	30 V	< 0.012 $\Omega$	12 A
	Q <sub>2</sub>	30 V	< 0.008 $\Omega$	15 A

- R<sub>DS(on)</sub> \* Q<sub>g</sub> industry benchmark
- Extremely low on-resistance R<sub>DS(on)</sub>
- Very low switching gate charge
- High avalanche ruggedness
- Low gate drive power losses

## Application

- Switching applications

## Description

This product utilizes latest generations of design rules of ST's proprietary STripFET™ V and STripFET™ VI DeepGATE technology. The lowest available R<sub>DS(on)</sub>\*Q<sub>g</sub>, in this chip scale package, makes this device suitable for the most demanding DC-DC converter applications, where high power density is to be achieved.

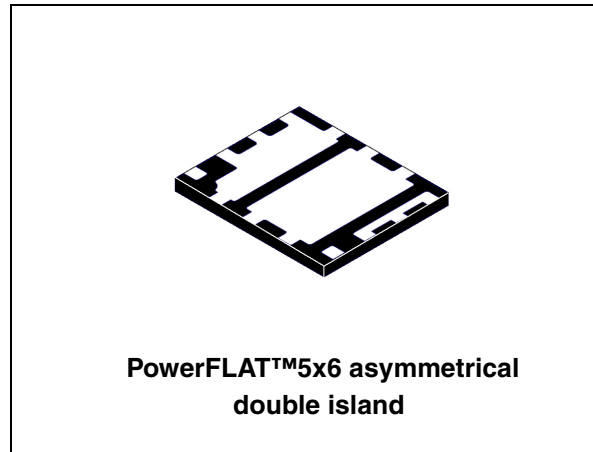


Figure 1. Internal schematic diagram

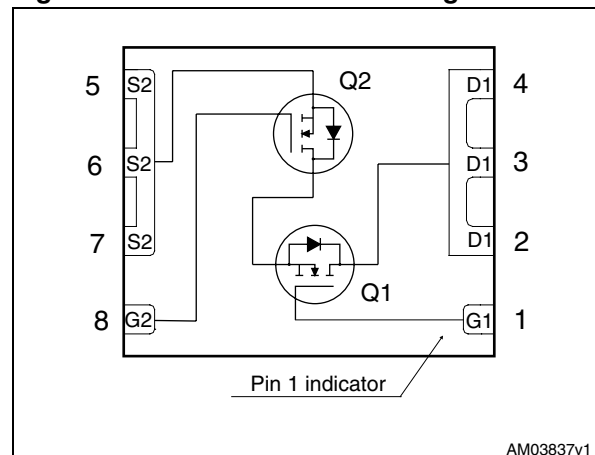


Table 1. Device summary

Order code	Marking	Package	Packaging
STL60N32N3LL	60N32N3LL	PowerFLAT™5x6 asymmetrical double island	Tape and reel

# Contents

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Type	Value	Unit
V <sub>DS</sub>	Drain-source voltage (v <sub>GS</sub> = 0)	Q <sub>1</sub>	30	V
		Q <sub>2</sub>	30	V
V <sub>GS</sub>	Gate- source voltage	Q <sub>1</sub>	± 22	V
		Q <sub>2</sub>	± 20	V
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 25°C	Q <sub>1</sub>	32	A
		Q <sub>2</sub>	60	A
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 100°C	Q <sub>1</sub>	20	A
		Q <sub>2</sub>	37	A
I <sub>D</sub> <sup>(2)</sup>	Drain current (continuous) at T <sub>C</sub> = 25°C	Q <sub>1</sub>	12	A
		Q <sub>2</sub>	15	A
I <sub>D</sub> <sup>(2)</sup>	Drain current (continuous) at T <sub>C</sub> = 100°C	Q <sub>1</sub>	7.5	A
		Q <sub>2</sub>	9	A
I <sub>DM</sub> <sup>(3)</sup>	Drain current (pulsed)	Q <sub>1</sub>	48	A
		Q <sub>2</sub>	60	A
P <sub>TOT</sub> <sup>(1)</sup>	Total dissipation at T <sub>C</sub> = 25°C	Q <sub>1</sub>	23	W
		Q <sub>2</sub>	50	W
P <sub>TOT</sub> <sup>(2)</sup>	Total dissipation at T <sub>C</sub> = 25°C	Q <sub>1</sub>	3.12	W
		Q <sub>2</sub>	3.12	W
E <sub>AS</sub> <sup>(4)</sup>	Single pulse avalanche energy		TBD	mJ

1. This value is accordingly R<sub>thj-c</sub>
2. This value is accordingly R<sub>thj-pcb</sub>
3. Pulse width limited by safe operating area
4. Starting T<sub>J</sub> = 25 °C, I<sub>D</sub> = 7.5 A

**Table 3. Thermal data**

Symbol	Parameter	Type	Value	Unit
R <sub>thj-pcb</sub> <sup>(1)</sup>	Thermal resistance junction-ambient max		40	°C/W
R <sub>thj-c</sub>	Thermal resistance junction-case	Q <sub>1</sub>	5.5	°C/W
		Q <sub>2</sub>	2.5	
T <sub>j</sub>	Thermal operating junction-ambient		150	°C
T <sub>stg</sub>	Storage temperature		-55 to 150	°C

1. When mounted on FR-4 board of 1inch<sup>2</sup>, 2oz Cu, t < 10 sec

## 2 Electrical characteristics

( $T_{CASE}=25^{\circ}C$  unless otherwise specified)

**Table 4. On/off states**

Symbol	Parameter	Test conditions	Type	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source Breakdown voltage	$I_D = 250 \mu A, V_{GS} = 0$	Q <sub>1</sub>	30			V
			Q <sub>2</sub>	30			V
$I_{DSS}$	Zero gate voltage Drain current ( $V_{GS} = 0$ )	$V_{DS} = \text{Max rating}$	Q <sub>1</sub>			1	$\mu A$
			Q <sub>2</sub>			1	$\mu A$
$I_{DSS}$	Zero gate voltage Drain current ( $V_{GS} = 0$ )	$V_{DS} = \text{Max rating}$ @ 125°C	Q <sub>1</sub>			10	$\mu A$
			Q <sub>2</sub>			10	$\mu A$
$I_{GSS}$	Gate-body leakage current ( $V_{DS} = 0$ )	$V_{GS} = \pm 22 V$	Q <sub>1</sub>			$\pm 100$	nA
			Q <sub>2</sub>			$\pm 100$	nA
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS},$ $I_D = 250 \mu A$	Q <sub>1</sub>	1			V
			Q <sub>2</sub>	1			V
$R_{DS(on)}$	Static drain-source on resistance	$V_{GS} = 10 V, I_D = 6 A$ $V_{GS} = 10 V, I_D = 7.5 A$	Q <sub>1</sub>		0.01	0.12	$\Omega$
			Q <sub>2</sub>		0.006	0.008	$\Omega$
$R_{DS(on)}$	Static drain-source on resistance	$V_{GS} = 4.5 V, I_D = 6 A$ $V_{GS} = 4.5 V, I_D = 7.5 A$	Q <sub>1</sub>		0.0115	0.014	$\Omega$
			Q <sub>2</sub>		0.009	0.011	$\Omega$

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Type	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{DS} = 25 V, f = 1 \text{ MHz},$ $V_{GS} = 0$	Q <sub>1</sub>	-	1020	-	pF
			Q <sub>2</sub>	-	1690	-	pF
$C_{oss}$	Output capacitance		Q <sub>1</sub>	-	200	-	pF
			Q <sub>2</sub>	-	291	-	pF
$C_{rss}$	Reverse transfer capacitance		Q <sub>1</sub>	-	26	-	pF
			Q <sub>2</sub>	-	176	-	pF
$Q_g$	Total gate charge	$V_{DD} = 15 V, I_D = 15 A,$ $V_{GS} = 4.5 V$ (see Figure 3)	Q <sub>1</sub>	-	7	-	nC
			Q <sub>2</sub>	-	17	-	nC
$Q_{gs}$	Gate-source charge		Q <sub>1</sub>	-	TBD	-	nC
			Q <sub>2</sub>	-	TBD	-	nC
$Q_{gd}$	Gate-drain charge		Q <sub>1</sub>	-	TBD	-	nC
			Q <sub>2</sub>	-	TBD	-	nC

Table 6. Switching times

Symbol	Parameter	Test conditions	Type	Min.	Typ.	Max.	Unit
$t_{d(on)}$ $t_r$	Turn-on delay time Rise time	$V_{DD}=15\text{ V}$ , $I_D=7.5\text{ A}$ , $R_G=4.7\ \Omega$ , $V_{GS}=4.5\text{ V}$ (see Figure 7)	$Q_1$	-	TBD	-	ns
			$Q_2$				ns
			$Q_1$				ns
			$Q_2$				ns
$t_{d(off)}$ $t_f$	Turn-off delay time Fall time	$V_{DD}=15\text{ V}$ , $I_D=7.5\text{ A}$ , $R_G=4.7\ \Omega$ , $V_{GS}=4.5\text{ V}$ (see Figure 7)	$Q_1$	-	TBD	-	ns
			$Q_2$				ns
			$Q_1$				ns
			$Q_2$				ns

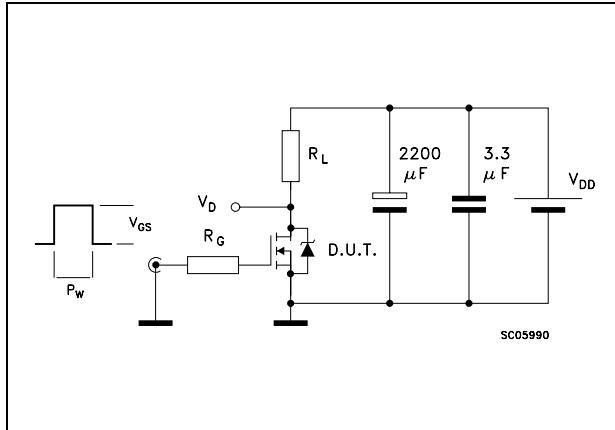
Table 7. Source drain diode

Symbol	Parameter	Test conditions	Type	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current	$V_{DD}=15\text{ V}$ , $I_D=7.5\text{ A}$ , $R_G=4.7\ \Omega$ , $V_{GS}=4.5\text{ V}$	$Q_1$	-		12	A
			$Q_2$			15	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)	$V_{DD}=15\text{ V}$ , $I_D=7.5\text{ A}$ , $R_G=4.7\ \Omega$ , $V_{GS}=4.5\text{ V}$	$Q_1$	-		48	A
			$Q_2$			60	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD}=15\text{ A}$ , $V_{GS}=0$	$Q_1$	-		1.1	V
			$Q_2$			1.1	V
$t_{rr}$	Reverse recovery time	$I_{SD}=15\text{ A}$ , $V_{DD}=15\text{ V}$ $di/dt=100\text{ A}/\mu\text{s}$ , $T_j=150^\circ\text{C}$ (see Figure 7)	$Q_1$	-		TBD	ns
$Q_{rr}$	Reverse recovery charge		$Q_2$			TBD	ns
			$Q_1$			TBD	nC
$I_{RRM}$	Reverse recovery current		$Q_2$			TBD	nC
		$Q_1$	TBD	A			
			$Q_2$			TBD	A

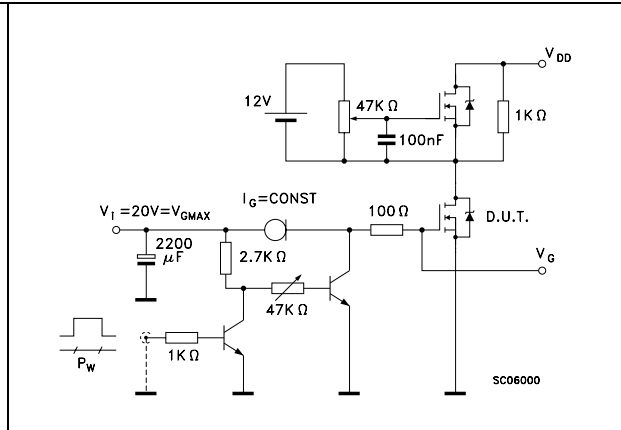
1. Pulse width limited by safe operating area.
2. Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

### 3 Test circuits

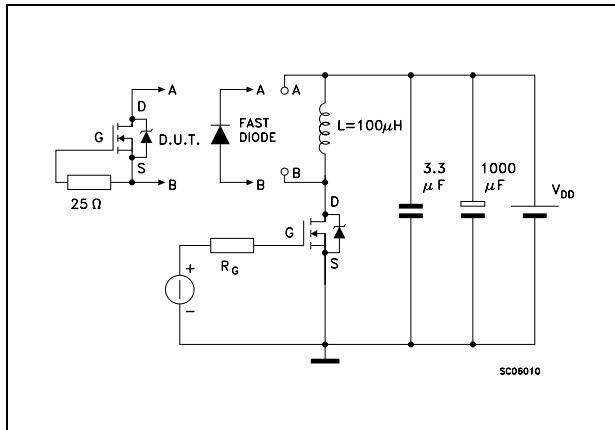
**Figure 2. Switching times test circuit for resistive load**



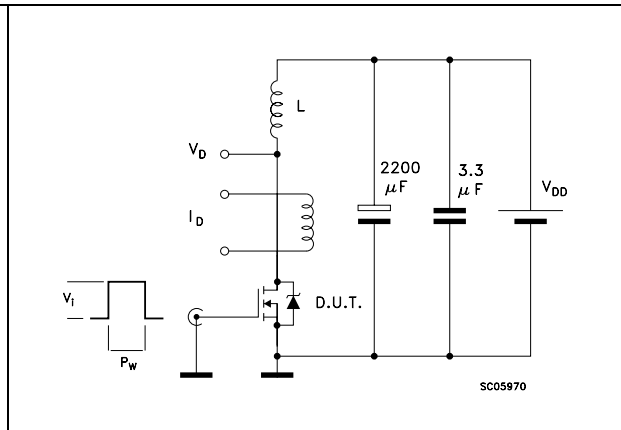
**Figure 3. Gate charge test circuit**



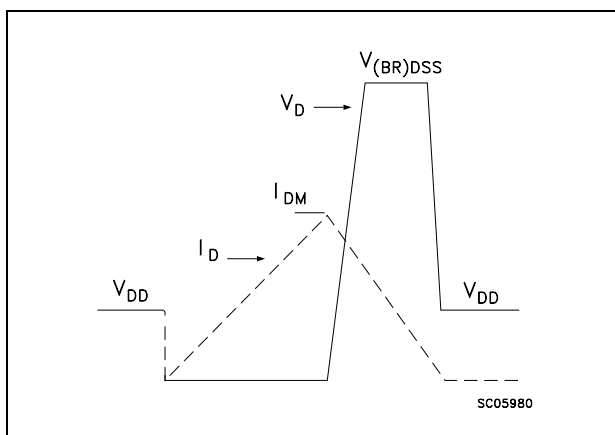
**Figure 4. Test circuit for inductive load switching and diode recovery times**



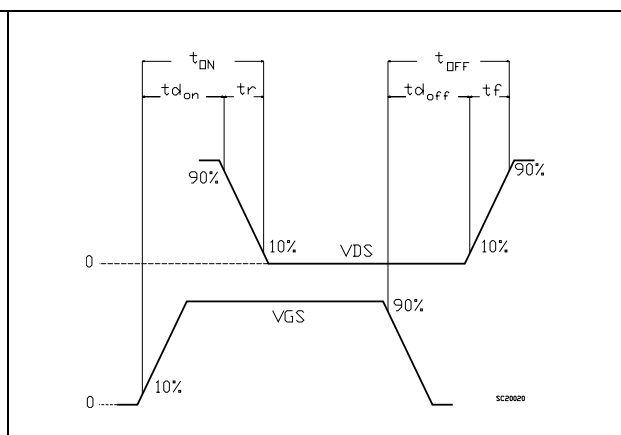
**Figure 5. Unclamped inductive load test circuit**



**Figure 6. Unclamped inductive waveform**



**Figure 7. Switching time waveform**



## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

**Table 8. PowerFLAT™ 5x6 asymmetrical double island dimensions**

Dim.	mm		
	Min.	Typ.	Max.
A	0.77		0.97
A1			0.03
b	0.42		0.52
D	4.90	5.00'	5.10
D2	2.40		2.60
E	5.90	6.00	6.10
E2	2.90		3.10
e		1.27	
L	0.40		0.60

**Figure 8. Package drawing**

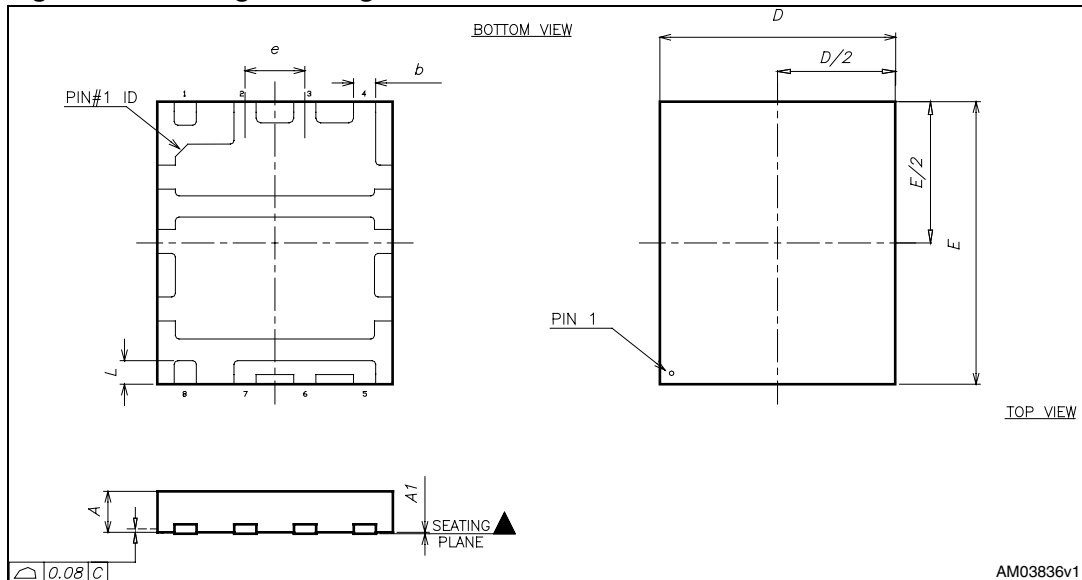
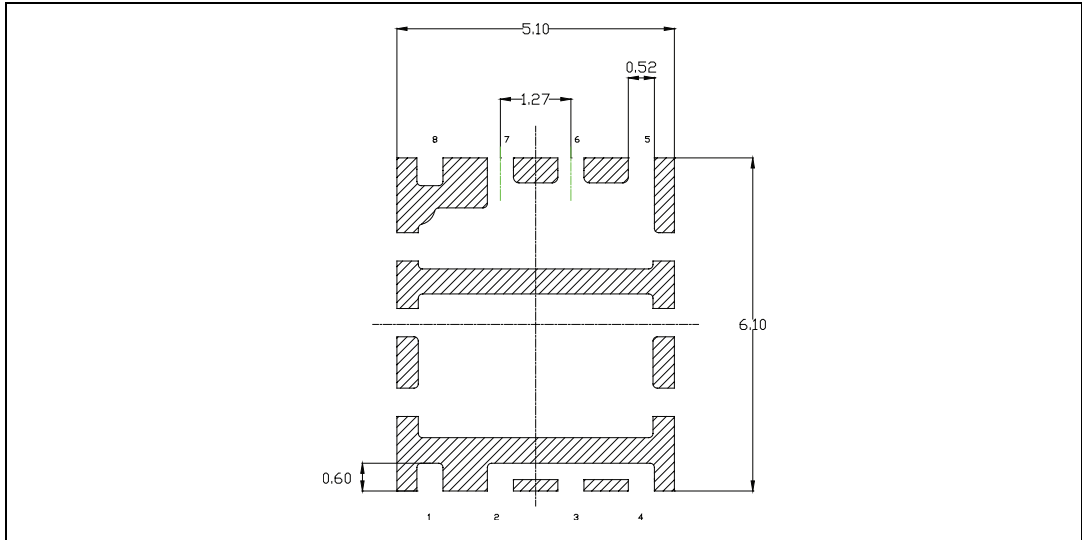


Figure 9. Recommended footprint (dimensions are in mm)





## 5 Revision history

Table 9. Document revision history

Date	Revision	Changes
15-Mar-2010	1	First release

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